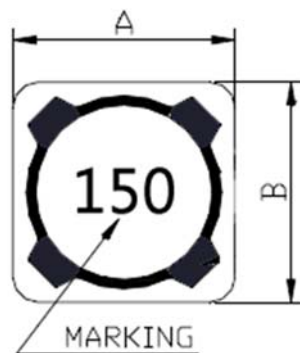
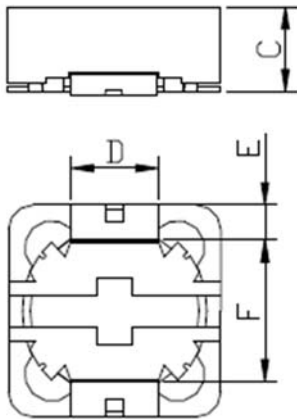


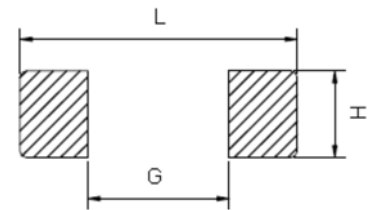
FEATRLRES

- Magnetic Shielded surface mount inductor with high current rating.
- Low resistance to keep power loss minimum.
- 100% Lead(Pb) & Halogen-Free and RoHS compliant.

CONFIGLRATIONS & DIMENSIONS (unit in mm)



Recommended Land pattern



Size	A	B	C	D	E	F
HSB127	12.8 max.	12.8 max.	8.5max.	5.0 ref.	2.2 ref.	7.6 ref.

L	G	H
12.6	7.0	5.4

ELECTRICAL CHARACTERISTICS

Part Number	Inductance(uH)	Tolerance (%)	Test Frequency(Hz)	DCR (Ω) max.	IDC (A) max.
HSB127-1R2Y	1.2	± 30%	1V/100K	0.0070	9.80
HSB127-2R2Y	2.2	±30%	1V/100K	0.0115	8.00
HSB127-2R4Y	2.4	± 30%	1V/100K	0.0115	8.00
HSB127-3R3Y	3.3	± 30%	1V/100K	0.0135	12.00
HSB127-3R5Y	3.5	± 30%	1V/100K	0.0135	7.50
HSB127-4R7Y	4.7	± 30%	1V/100K	0.0158	6.80
HSB127-6R1Y	6.1	± 30%	1V/100K	0.0176	6.60
HSB127-6R8Y	6.8	±30%	1V/100K	0.0185	6.20
HSB127-7R6Y	7.6	± 30%	1V/100K	0.0200	5.90
HSB127-100M	10	± 20%	1V/1K	0.0216	5.40
HSB127-120M	12	± 20%	1V/1K	0.0243	4.90
HSB127-150M	15	± 20%	1V/1K	0.0270	4.50

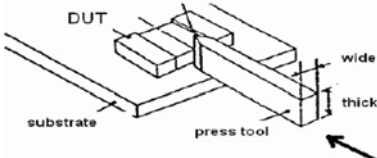
HSB127-180M	18	± 20%	1V/1K	0.0392	3.90
HSB127-220M	22	± 20%	1V/1K	0.0432	3.60
HSB127-270M	27	± 20%	1V/1K	0.0459	3.40
HSB127-330M	33	± 20%	1V/1K	0.0648	3.00
HSB127-390M	39	± 20%	1V/1K	0.0729	2.75
HSB127-470M	47	± 20%	1V/1K	0.1000	2.50
HSB127-560M	56	± 20%	1V/1K	0.1100	2.35
HSB127-680M	68	± 20%	1V/1K	0.1400	2.10
HSB127-820M	82	± 20%	1V/1K	0.1600	1.95
HSB127-101M	100	± 20%	1V/1K	0.2200	1.70
HSB127-121M	120	± 20%	1V/1K	0.2500	1.60
HSB127-151M	150	± 20%	1V/1K	0.2800	1.42
HSB127-181M	180	± 20%	1V/1K	0.3500	1.30
HSB127-221M	220	± 20%	1V/1K	0.3900	1.16
HSB127-271M	270	± 20%	1V/1K	0.5600	1.06
HSB127-331M	330	± 20%	1V/1K	0.6400	0.95
HSB127-391M	390	± 20%	1V/1K	0.7000	0.88
HSB127-471M	470	± 20%	1V/1K	0.9800	0.79
HSB127-561M	560	± 20%	1V/1K	1.0700	0.73
HSB127-681M	680	± 20%	1V/1K	1.4600	0.67
HSB127-821M	820	± 20%	1V/1K	1.6400	0.60
HSB127-102M	1000	± 20%	1V/1K	1.8200	0.55

Note:

Based on inductance change ($\Delta L/L0$: $\leq -35\%$) @ ambient temp. 25°C Based on temperature rise (ΔT : 40°C typ.)

Reliability and Test Condition

Item	Performance	Test Condition
Operating temperature	-40~+125°C (Including self - temperature rise)	
Storage temperature	1. -10~+40°C, 50~60%RH (Product with taping) 2. -40~+125°C (on board)	
Electrical Performance Test		
Inductance	Refer to standard electrical characteristics list.	HP4284A, CH11025, CH3302, CH1320, CH1320S LCR Meter.
DCR		CH16502, Agilent33420A Micro-Ohm Meter.
Saturation Current (Isat)	Approximately $\Delta L30\%$	Saturation DC Current (Isat) will cause L0 to drop $\Delta L(\%)$
Heat Rated Current (Irms)	Approximately $\Delta T40^\circ\text{C}$	Heat Rated Current (Irms) will cause the coil temperature rise $\Delta T(^\circ\text{C})$. 1. Applied the allowed DC current 2. Temperature measured by digital surface thermometer
Reliability Test		

Life Test		Preconditioning: Run through IR reflow for 2 times.(IPC/JEDEC J-STD-020DClassification Reflow Profiles) Temperature : 125±2°C (Inductor) Applied current : rated current Duration : 1000±12hrs Measured at room temperature after placing for 24±2 hrs															
Load Humidity		Preconditioning: Run through IR reflow for 2 times.(IPC/JEDEC J-STD-020DClassification Reflow Profiles) Humidity : 85±2 × R.H, Temperature : 85°C±2°C Duration : 1000hrs Min. with 100% rated current Measured at room temperature after placing for 24±2 hrs															
Moisture Resistance	Appearance : No damage. Inductance : within±10% of initial value Q : Shall not exceed the specification value. RDC : within ±15% of initial value and shall not exceed the specification value	Preconditioning: Run through IR reflow for 2 times.(IPC/JEDEC J-STD-020DClassification Reflow Profiles) Profiles 1. Baked at50°C for 25hrs, measured at room temperature after placing for 4 hrs. 2. Raise temperature to 65±2°C 90-100%RH in 2.5hrs, and keep 3 hours, cool down to 25°C in 2.5hrs. 3. Raise temperature to 65±2°C 90-100%RH in 2.5hrs, and keep 3 hours, cool down to 25°C in 2.5hrs,keep at 25°C for 2 hrs then keep at -10°C for 3 hrs 4. Keep at 25°C 80-100%RH for 15min and vibrate at the frequency of 10 to 55 Hz to 10 Hz, measure at room temperature after placing for 1~2 hrs.															
Thermal shock		Preconditioning: Run through IR reflow for 2 times.(IPC/JEDEC J-STD-020DClassification Reflow Profiles Condition for 1 cycle Step1 : -40±2°C 30±5min Step2 : 25±2°C ≤0.5min Step3 : 125±2°C 30±5min Number of cycles : 500 Measured at room temperature after placing for 24±2 hrs															
Vibration		Oscillation Frequency: 10 ~ 2K ~ 10Hz for 20 minutes Equipment : Vibration checker Total Amplitude:1.52mm±10% Testing Time : 12 hours(20 minutes, 12 cycles each of 3 orientations).															
Bending		Shall be mounted on a FR4 substrate of the following dimensions: >=0805 inch(2012mm):40x100x1.2mm <0805 inch(2012mm):40x100x0.8mm Bending depth: >=0805 inch(2012mm):1.2mm <0805 inch(2012mm):0.8mm duration of 10 sec.															
Shock	Appearance : No damage. Impedance : within±15% of initial value Inductance : within±10% of initial value Q : Shall not exceed the specification value. RDC : within ±15% of initial value and shall not exceed the specification value	<table border="1"> <thead> <tr> <th>Type</th> <th>Peak value (g's)</th> <th>Normal duration (D) (ms)</th> <th>Wave form</th> <th>Velocity change (Vi)ft/sec</th> </tr> </thead> <tbody> <tr> <td>SMD</td> <td>50</td> <td>11</td> <td>Half-sine</td> <td>11.3</td> </tr> <tr> <td>Lead</td> <td>50</td> <td>11</td> <td>Half-sine</td> <td>11.3</td> </tr> </tbody> </table>	Type	Peak value (g's)	Normal duration (D) (ms)	Wave form	Velocity change (Vi)ft/sec	SMD	50	11	Half-sine	11.3	Lead	50	11	Half-sine	11.3
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SMD	50	11	Half-sine	11.3													
Lead	50	11	Half-sine	11.3													
Solder ability	More than 95% of the terminal electrode should be covered with solder.	Preheat: 150°C,60sec.. Solder: Sn96.5% Ag3% Cu0.5% Temperature: 245±5°C ◦ Flux for lead free: Rosin. 9.5% ◦ Dip time: 4±1sec ◦ Depth: completely cover the termination															
Resistance to Soldering Heat		Depth: completely cover the termination <table border="1"> <thead> <tr> <th>Temperature(°C)</th> <th>Time(s)</th> <th>Temperature ramp/immersion and emersion rate</th> <th>Number of heat cycles</th> </tr> </thead> <tbody> <tr> <td>260 ±5 (solder temp)</td> <td>10 ±1</td> <td>25mm/s ±6 mm/s</td> <td>1</td> </tr> </tbody> </table>	Temperature(°C)	Time(s)	Temperature ramp/immersion and emersion rate	Number of heat cycles	260 ±5 (solder temp)	10 ±1	25mm/s ±6 mm/s	1							
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260 ±5 (solder temp)	10 ±1	25mm/s ±6 mm/s	1														
Terminal Strength	Appearance : No damage. Impedance : within±15% of initial value Inductance : within±10% of initial value Q : Shall not exceed the specification value. RDC : within ±15% of initial value and shall not exceed the specification value e	Preconditioning: Run through IR reflow for 2 times.(IPC/JEDEC J-STD-020DClassification Reflow Profiles With the component mounted on a PCB with the device to be tested, apply a force(>0805:1kg , <=0805:0.5kg)to the side of a device being tested. This force shall be applied for 60 +1 seconds. Also the force shall be applied gradually as not to apply a shock to the component being tested. 															

Note : When there are questions concerning measurement result : measurement shall be made after 48 ± 2 hours of recovery under the standard condition.